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CERTIFICATE OF ANALYSIS

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1.0 ACCREDITATION / REGISTRATION

INORGANIC VENTURES is accredited to ISO 17034, "General Requirements for the Competence of Reference Material Producers" and ISO/IEC 17025, "General Requirements for the Competence of Testing and Calibration Laboratories". Inorganic Ventures is also an ISO 9001 registered manufacturer (QSR Certificate Number QSR-1034).



2.0 PRODUCT DESCRIPTION

Product Code: Single Analyte Custom Grade Solution

Catalog Number: CGSI10

Lot Number: P2-SI685281

Matrix: 1% (v/v) HNO3

1.4% (v/v) HF

Value / Analyte(s): 10 000 µg/mL ea:

Silicon

Starting Material: Fused Silica

Starting Material Lot#: 1771

Starting Material Purity: 99.9937%

3.0 CERTIFIED VALUES AND UNCERTAINTIES

Certified Value: $10026 \pm 50 \mu g/mL$

Density: 1.046 g/mL (measured at 20 \pm 4 °C)

Assay Information:

Assay Method #1 $10017 \pm 51 \mu g/mL$

ICP Assay NIST SRM 3150 Lot Number: 130912

Assay Method #2 10041 ± 68 μg/mL

Calculated NIST SRM Lot Number: See Sec. 4.2

- The Calculated Value is a value calculated from the weight of a starting material that has been certified directly vs. a National Institute of Standards and Technology (NIST) SRM/RM. See Sec 4.2 for balance traceability.

The following equations are used in the calculation of the certified value and the uncertainty. Reported uncertainties represent expanded uncertainties expressed at approximately the 95% confidence level using a coverage factor of k = 2.

Characterization of CRM/RM by Two or More Methods Characterization of CRM/RM by One Method Certified Value, X_{CRM/RM}, where two or more methods of characterization are Certified Value, $X_{CRM/RM}$, where one method of characterization used is the weighted mean of the results: is used is the mean of individual results: $X_{CRM/RM} = \Sigma(w_i) (X_i)$ $X_{CRM/RM} = (X_a) (u_{char} a)$ X_i = mean of Assay Method i with standard uncertainty u_{char i} Xa = mean of Assay Method A with **w**_i = the weighting factors for each method calculated using the inverse square of u_{char a} = the standard uncertainty of characterization Method A $\mathbf{w_i} = (1/u_{\text{char i}})^2 / (\Sigma (1/(u_{\text{char i}})^2)$ CRM/RM Expanded Uncertainty (±) = $U_{CRM/RM} = k (u_{char}^2 + u_{bb}^2 + u_{lts}^2 + u_{ts}^2)^{1/2}$ CRM/RM Expanded Uncertainty (±) = $U_{CRM/RM} = k (u_{char}^2 a + u_{bb}^2 + u_{lts}^2 + u_{ts}^2)^{1/2}$ k = coverage factor = 2 k = coverage factor = 2 $\mathbf{u_{char}} = [\Sigma((\mathbf{w_i})^2 (\mathbf{u_{char}}_i)^2)]^{1/2}$ where $\mathbf{u_{char}}_i$ are the errors from each characterization method u_{char a} = the errors from characterization = bottle to bottle homogeneity standard uncertainty $\mathbf{u_{bb}}$ = bottle to bottle homogeneity standard uncertainty u_{lts} = long term stability standard uncertainty (storage) u_{lts} = long term stability standard uncertainty (storage) uts = transport stability standard uncertainty u_{ts} = transport stability standard uncertainty

4.0 TRACEABILITY TO NIST

- This product is traceable to NIST via an unbroken chain of comparisons. The uncertainties for each certified value are reported, taking into account the SRM/RM uncertainty error and the measurement, weighing and volume dilution errors. In rare cases where no NIST SRM/RM are available, the term 'in-house std.' is specified.

4.1 Thermometer Calibration

- All thermometers are NIST traceable through thermometers that are calibrated by an accredited calibration laboratory.

4.2 Balance Calibration

- All analytical balances are calibrated by an accredited calibration laboratory and procedure. The weights used for testing are annually compared to master weights and are traceable to NIST.

4.3 Glassware Calibration

- An in-house procedure is used to calibrate all Class A glassware used in the manufacturing and quality control of CRM/RMs.

5.0 TRACE METALLIC IMPURITIES (TMI) DETERMINED BY ICP-MS AND ICP-OES (µg/mL)

CRM/RMs are tested for trace metallic impurities by Axial ICP-OES and ICP-MS. The result from the most sensitive method for each element, is reported below. Solutions tested by ICP-MS were analyzed in an ULPA-Filtered Clean Room. An ULPA-Filter is 99.9985% efficient for the removal of particles down to 0.3 µm.

```
Ag <
          0.000300 M Eu <
                             0.000300 O Na
                                                0.036486 M Se <
                                                                  0.004400 M Zn <
                                                                                     0.007000
M
0
  ΑI
          0.315451 O Fe
                             0.038006 M
                                        Nb <
                                                0.000590 s
                                                           Si <
                                                                          M Zr
                                                                                     0.003344
М
  As <
          0.001200 M Ga <
                             0.000300 M Nd <
                                                0.000300 M Sm <
                                                                  0.000300
М
  Au <
          0.001800 M Gd <
                             0.000300 M
                                        Ni <
                                                0.018000 M Sn <
                                                                  0.014000
0
  В
          0.193831 M
                     Ge <
                             0.001200 M
                                        Os <
                                                0.003200 O
                                                          Sr
                                                                  0.005320
0
  Ва
          0.003268 M
                     Hf
                             0.026224 i
                                        P <
                                                       М
                                                           Ta
                                                                  0.002470
Ω
   Be <
          0.002300 M
                     Ha <
                             0.000300 M Pb <
                                                0.000590 M
                                                          Tb <
                                                                  0.000300
M
  Bi <
          0.000730 M
                     Ho <
                             0.000300 M
                                        Pd <
                                                0.000300 M
                                                           Te <
                                                                  0.002100
0
   Ca
          0.798131 M
                     In <
                             0.000300 M
                                        Pr <
                                                0.000300 M
                                                           Th <
                                                                  0.000300
M
   Cd <
          0.000300 M Ir
                             0.000300 M
                                        Pt <
                                                0.000590 O
                                                           Ti
                                                                  0.010261
                                                           TI <
M
   Ce <
          0.001200 O
                     Κ
                             0.018623 M
                                        Rb <
                                                0.006000 M
                                                                  0.000300
M
   Co <
          0.001200 M La <
                             0.000640 M
                                        Re <
                                                0.000300 M
                                                           Tm <
                                                                  0.000300
M
   Cr
          0.003344 O
                     Ιi
                             0.000456 M
                                        Rh <
                                                0.000300 M
                                                           U
                                                                  0.000300
M
   Cs <
          0.000300 M
                     Lu <
                             0.000300 M
                                        Ru <
                                                0.000300 O
                                                           V
                                                                  0.000680
M
   Cu <
          0.001200 O
                     Mg
                             0.057009 O
                                        S <
                                                0.850000 M
                                                          W
                                                              <
                                                                  0.001200
M
   Dy <
          0.000300 M
                     Mn <
                             0.004600 M
                                        Sb <
                                                0.000300 M
                                                          Υ
                                                              <
                                                                  0.000300
   Er <
          0.000300 M
                             O.000880 O
                                        Sc <
                                                0.000230 O Yb <
                                                                  0.000230
                     Mo <
```

M - Checked by ICP-MS O - Checked by ICP-OES i - Spectral Interference n - Not Checked For s - Solution Standard Element

6.0 INTENDED USE

- For the calibration of analytical instruments and validation of analytical methods as appropriate.

7.0 INSTRUCTIONS FOR THE CORRECT USE OF THIS REFERENCE MATERIAL

7.1 Storage and Handling Recommendations

- Store between approximately 4° 30° C while in sealed TCT bag.
- While stored in the sealed TCT bag, transpiration of this CRM/RM is negligible. After opening the sealed TCT bag transpiration of the CRM/RM will occur, resulting in a gradual increase in the analyte concentration(s). It is the responsibility of the user to account for this effect. When the bottle is weighed both before and after being placed in storage, the mass difference observed will be a measure of transpiration mass loss.
- After opening the sealed TCT bag, keep cap tightly sealed when not in use and store between 4° 24° C to minimize the effects of transpiration. Use at $20^{\circ} \pm 4^{\circ}$ C to minimize volumetric dilution error when using the reported density. Do not pipette from the container. Do not return removed aliquots to container.

- For more information, visit www.inorganicventures.com/TCT

Atomic Weight; Valence; Coordination Number; Chemical Form in Solution - 28.09 +4 6 Si(OH)x(F)y2-Chemical Compatibility -Soluble in HCl, HF, H3PO4 H2SO4 and HNO3 as the Si(OH)x(F)y2-. Avoid neutral to basic media. Unstable at ppm levels with metals that would pull F- away (i.e. Do not mix with Alkaline or Rare Earths, or high levels of transition elements unless they are fluorinated. Stable with most inorganic anions with a tendency to hydrolyze forming silicic acid (silicic acid is soluble up to ∼100 ppm in water) in all dilute acids except HF.

Stability - 2-100 ppb levels - stability unknown - (alone or mixed with all other metals) as the Si(OH)x(F)y2-. 1-10,000 ppm single element solutions as the Si(OH)x(F)y2- chemically stable for years in 2-5 % HNO3 / trace HF in a LDPE container.

Si Containing Samples (Preparation and Solution) -Metal (Soluble in 1:1:1 H2O / HF / HNO3); Oxide - SiO2, amorphic (dissolve by heating in 1:1:1 H2O / HF / HNO3); Oxide - quartz (fuse in Pt0 with Na2CO3); Geological Samples(fuse in Pt0with Na2CO3 followed by HCl solution of the fuseate); Organic Matrices containing silicates and non volatile silicon compounds (dry ash at 4500C in Pt0 and dissolve by gently warming with 1:1:1 H2O / HF / H2SO4 or fuse / ash with Na2CO3 and dissolve fuseate with HCl / H2O); Silicone Oils - dimethyl silicones depolymerize to form volatile monomer units when heated (Measure directly in alcoholic KOH / xylene mixture where sample is treated first with the KOH at 60-1000C to "unzip" the Si-O-Si polymeric structure or digest with conc. H2SO4 / H2O2 followed by cooling and dissolution of the dehydrated silica with HF.) Note that the direct analysis of silicone oils in an organic solvent will result in false high results due to high vapor pressure of volatile monomer units like hexamethylcyclotrisiloxane. The KOH forms the K2+Si(CH3)2O= salt which is not volatile at room temperature.

Atomic Spectroscopic Information (ICP-OES D.L.s are given as radial/axial view):

Technique/Line	Estimated D.L.	Order	Interferences (underlined indicates severe)	
ICP-MS 28 amu	4000 - 8000 ppt	N/A	N2, 12C16O	
ICP-OES 212.412 r	ım 0.02/0.01 μg/mL	1	Hf, Os, Mo, Ta	
ICP-OES 251.611 r	ım 0.012/0.003 μg/mL	1	Ta, U, Zn, Th	
ICP-OES 288.158 r	m 0.03/0.004 μg/mL	1	Ta, Ce, Cr, Cd, Th	

HF Note: This standard should not be prepared or stored in glass.

8.0 HAZARDOUS INFORMATION

- Please refer to the Safety Data Sheet for information regarding this CRM/RM.

9.0 HOMOGENEITY

- This solution was mixed according to an in-house procedure and is guaranteed to be homogeneous. Homogeneity data indicate that the end user should take a minimum sample size of 0.2 mL to assure homogeneity.

10.0 QUALITY STANDARD DOCUMENTATION

10.1 ISO 9001 Quality Management System Registration

- QSR Certificate Number QSR-1034

10.2 ISO/IEC 17025 "General Requirements for the Competence of Testing and Calibration Laboratories"

- Chemical Testing - Accredited / A2LA Certificate Number 883.01

10.3 ISO 17034 "General Requirements for the Competence of Reference Material Producers"

- Reference Material Producer - Accredited / A2LA Certificate Number 883.02

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11.0 CERTIFICATION, LOT EXPIRATION AND PERIOD OF VALIDITY

11.1 Certification Issue Date

December 17, 2019

- The certification is valid within the measurement uncertainty specified provided the CRM/RM is stored and handled in accordance with instructions given in Sec 7.1. This certification is nullified if instructions in Sec 7.1 are not followed or if the CRM/RM is damaged, contaminated, or otherwise modified.

11.2 Lot Expiration Date

- December 17, 2023
- The date after which this CRM/RM should not be used.
- The lot expiration date reflects the period of time that the stability of a CRM/RM can be supported by long term stability studies conducted on properly stored and handled CRM/RMs. Lot expiration is limited primarily by transpiration (loss of water from the solution) and infrequently by chemical stability.

11.3 Period of Validity

Sealed TCT Bag	Open Date:	
Ocalca I O I Dag	Open Date.	

- This CRM/RM should not be used longer than one year (or six months in the case of a 30 mL bottle) from the date of opening the aluminized bag or after the date given in Sec. 11.2, whichever comes first. This is contingent upon the CRM/RM being stored and handled in accordance with the instructions given in Sec. 7.1.

12.0 NAMES AND SIGNATURES OF CERTIFYING OFFICERS Certificate Approved By:

Michael Booth Manager, Quality Control Michael 2 Booth

Paul R Sine

Certifying Officer:

Paul Gaines CEO, Senior Technical Director